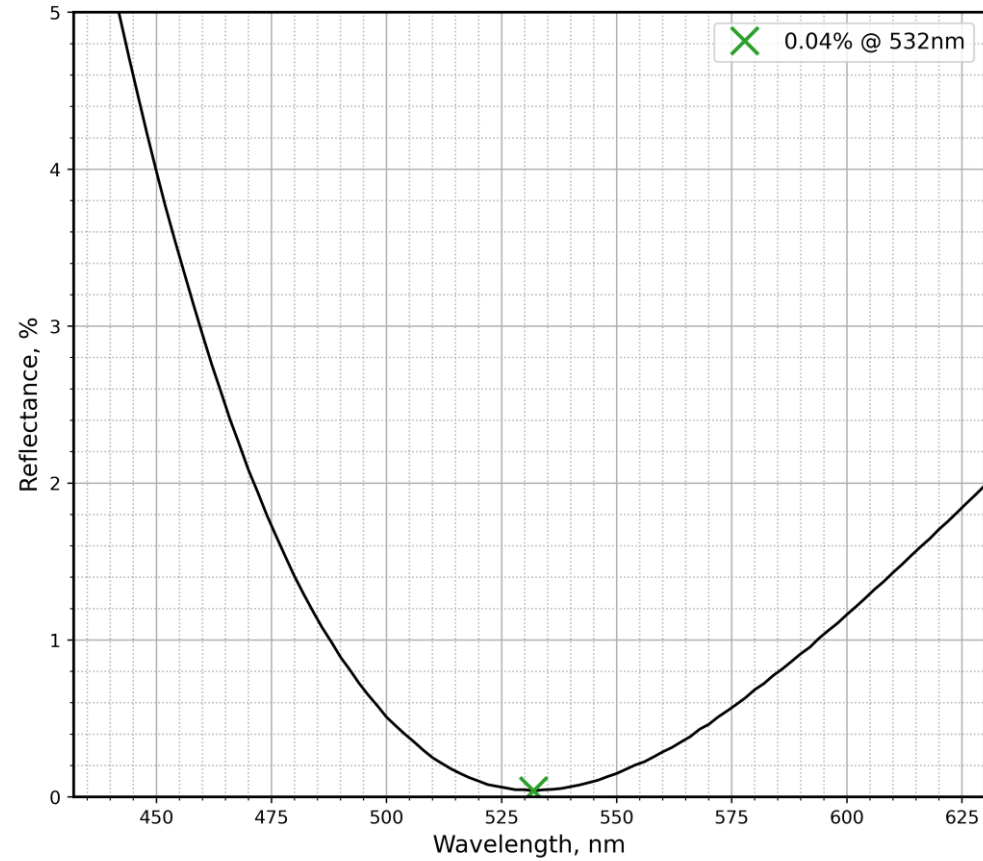


S1: AR<0.1% @ 532 nm, AOI 0 deg.
S2: AR<0.1% @ 532 nm, AOI 0 deg.



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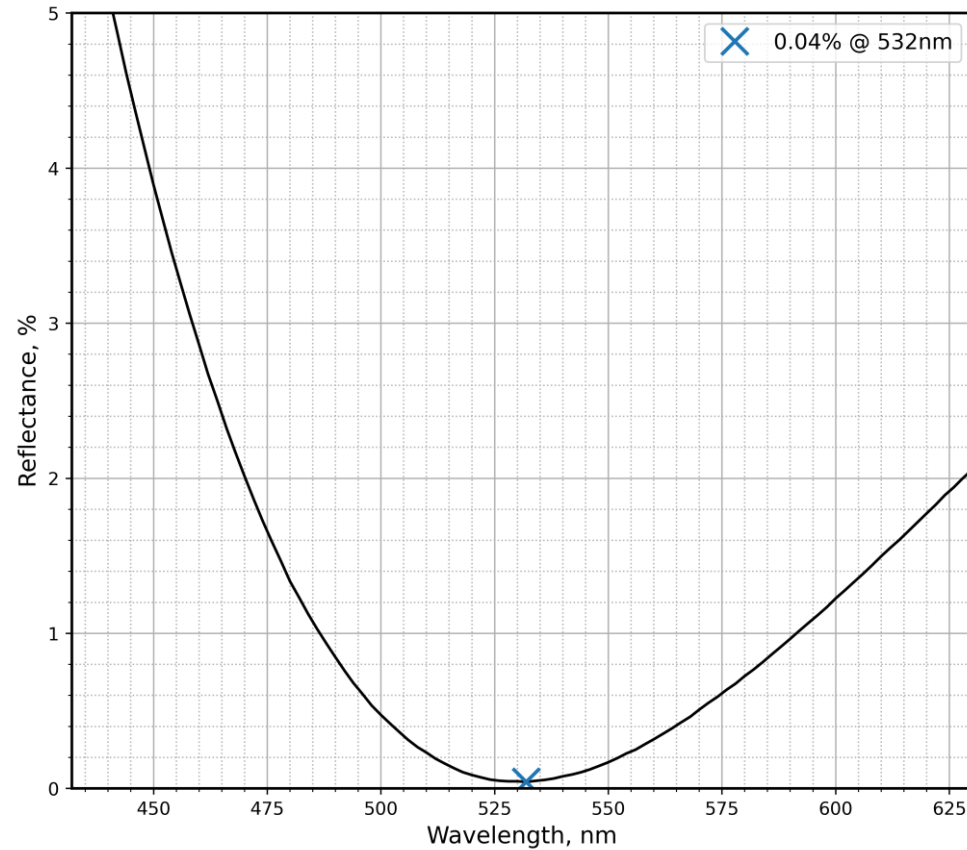
Fig. 1.

SIDE MEASURED: S1 only (grinded witness sample)

COMMENTS:

S1: AR<0.1% @ 532 nm, AOI 0 deg.

S2: AR<0.1% @ 532 nm, AOI 0 deg.



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Fig. 2.

SIDE MEASURED: S2 only (grinded witness sample)

COMMENTS: